

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/611,623	HSIAO ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Paul D Kim	3729	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,570,391	05-2003	Liang Lim et al.	324/525
	B	US-6,246,553	06-2001	Biskeborn, Robert G.	360/323
	C	US-6,221,559	04-2001	Lee et al.	430/311
	D	US-5,208,535	05-1993	Nakayama et al.	324/318
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08061955 A	03-1996	Japan	KURIHARA, KAZUO	G01C 17/32
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Study of magnetic tunnel junction read sensors" Ho, M.K.; Tsang, C.H.; Fontana, R.E., Jr.; Parkin, S.S.; Carey, K.J.; Tao Pan; MacDonald, S.; Arnett, P.C.; Moore, J.O.; IEEE Transactions on , Volume: 37 , Issue: 4 , July 2001 Pages:1691 - 1694.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.